



10/27/05

SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
061282-0055

SERIAL NO.
10/757,388

APPLICANT
KOBAYASHI, TAKESHI, et al.

FILING DATE
January 15, 2004

GROUP
2814

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
		JP 9-162348	06/20/1997	FUJITSU LTD		JAPAN (w/ English Abstract)

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

David H. Meyer

DATE CONSIDERED

1/18/07

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.



11/6/06

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Takeshi KOBAYASHI, et al.

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
AL7		US 6,339,261 B1	01/15/2002	Yonemochi et al.	
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ² -Number + Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
AL7		EP 0 977 259 A2	02/02/2000	Fujitsu Limited		X	
		EP 0 989 587 A2	05/10/2000	Shinko Electric Industries Co. Ltd.		X	
		EP 0 645 952 A1	03/29/1995	Rogers Corporation		X	
		JP 11 067838	03/09/1999	Matsushita Electric Industrial Co., Ltd.		English Abstract	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

Delia Skyles

DATE CONSIDERED

11/19/07

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